

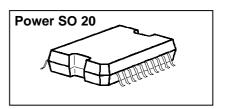
# Smart High-Side Power Switch Four Channels: $4 \times 90 \text{m}\Omega$

#### Status Feedback

#### **Product Summary**

Operating Voltage	$V_{bb}$	5.540V		
	Active channels	one	four parallel	
On-state Resistance	R <sub>ON</sub>	$90 m\Omega$	22.5mΩ	
Nominal load current	I <sub>L(NOM)</sub>	4.7A	19.0A	
Current limitation	$I_{L(SCr)}$	12A	12A	

#### **Package**



#### **General Description**

- N channel vertical power MOSFET with charge pump, ground referenced CMOS compatible input and diagnostic feedback, monolithically integrated in Smart SIPMOS® technology.
- Providing embedded protective functions

#### **Applications**

- μC compatible high-side power switch with diagnostic feedback for 12V and 24V grounded loads
- All types of resistive, inductive and capacitve loads
- Most suitable for loads with high inrush currents, so as lamps
- · Replaces electromechanical relays, fuses and discrete circuits

#### **Basic Functions**

- Very low standby current
- CMOS compatible input
- Improved electromagnetic compatibility (EMC)
- Fast demagnetization of inductive loads
- Stable behaviour at undervoltage
- Wide operating voltage range
- Logic ground independent from load ground

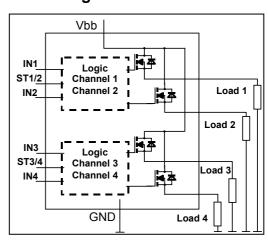
#### **Protection Functions**

- Short circuit protection
- Overload protection
- Current limitation
- Thermal shutdown
- Overvoltage protection (including load dump) with external resistor
- Reverse battery protection with external resistor
- Loss of ground and loss of V<sub>bb</sub> protection
- Electrostatic discharge protection (ESD)

#### **Diagnostic Function**

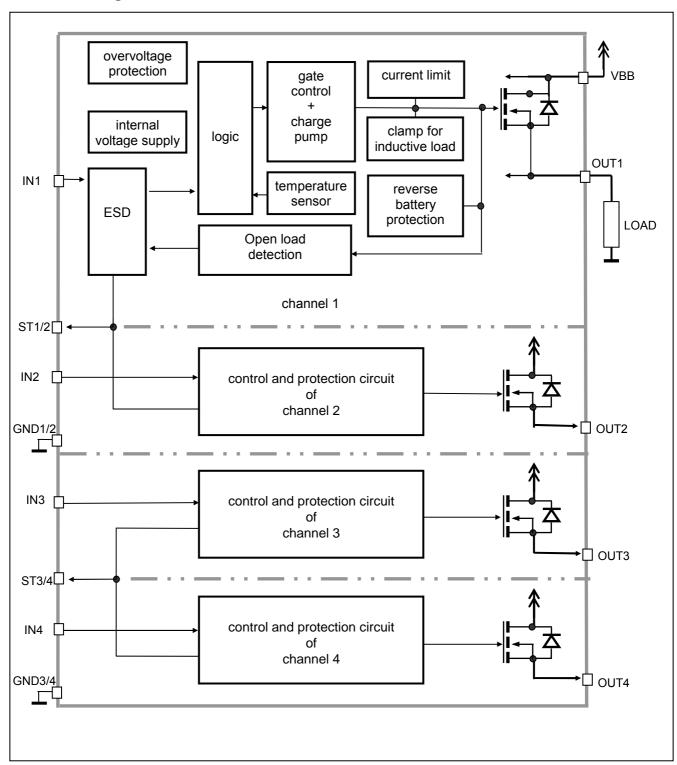
- Diagnostic feedback with open drain output
- Open load detection in OFF-state
- Feedback of thermal shutdown in ON-state

#### **Block Diagram**





#### **Functional diagram**





### **Pin Definitions and Functions**

Pin	Symbol	Function
1,10,	V <sub>bb</sub>	Positive power supply voltage. Design the
11,20		wiring for the simultaneous max. short circuit
		currents from channel 1 to 2 and also for low
		thermal resistance
3	IN1	Input 1,2, 3,4 activates channel 1,2,3,4 in case
5	IN2	of logic high signal
7	IN3	
9	IN4	
18,19	OUT1	Output 1,2,3,4 protected high-side power output
16,17	OUT2	of channel 1,23,4. Design the wiring for the
14,15	OUT3	max. short circuit current
12,13	OUT4	
4	ST1/2	Diagnostic feedback 1/2,3/4 of channel 1,2,3,4
8	ST3/4	open drain, low on failure
2	GND1/2	Ground of chip 1 (channel 1,2)
6	GND3/4	Ground of chip 2 (channel 3,4)

### Pin configuration

(top view	)		
V <sub>bb</sub> GND1/2 IN1 ST1/2 IN2 GND3/4	1 • 2 3 4 5 6	20 19 18 17 16	V <sub>bb</sub> OUT1 OUT1 OUT2 OUT2 OUT3
IN3 ST3/4 IN4	7 8 9	14 13 12	OUT3 OUT4 OUT4
V <sub>bb</sub>	10	11	V <sub>bb</sub>



## **Maximum Ratings** at $T_j = 25$ °C unless otherwise specified

Parameter	Symbol	Values	Unit
Supply voltage (overvoltage protection see page 6)	$V_{ m bb}$	43	V
Supply voltage for full short circuit protection $T_{j,\text{start}} = -40 \dots +150^{\circ}\text{C}$	$V_{ m bb}$	36	V
Load current (Short-circuit current, see page 6)	<b>/</b> ∟	self-limited	Α
Load dump protection <sup>1)</sup> $V_{\text{LoadDump}} = V_{\text{A}} + V_{\text{S}}$ , $V_{\text{A}} = 13.5 \text{ V}$ $R_{\text{I}}^{(2)} = 2 \Omega$ , $t_{\text{d}} = 400 \text{ ms}$ ; IN = low or high, each channel loaded with $R_{\text{L}} = 13.5 \Omega$ ,	V <sub>Load dump</sub> <sup>3)</sup>	60	V
Operating temperature range	T <sub>j</sub>	-40+150	°C
Storage temperature range	$T_{ m stg}$	-55+150	
Power dissipation (DC) <sup>4)</sup> $T_a = 25$ °C:	P <sub>tot</sub>	3.6	W
(all channels active) $T_a = 85$ °C:		1.9	
Maximal switchable inductance, single pulse $V_{bb} = 12V$ , $T_{i,start} = 150^{\circ}C^{4}$ , see diagrams on page 10			
$I_1 = 4.7 \text{ A}, E_{AS} = 120 \text{ mJ}, 0\Omega$ one channel:	$Z_{L}$	7.9	mH
$I_1 = 9.5 \text{ A}$ , $E_{AS} = 230 \text{ mJ}$ , $0\Omega$ two parallel channels:		3.7	
$I_L = 19.0 \text{ A}$ , $E_{AS} = 450 \text{ mJ}$ , $0\Omega$ four parallel channels:		1.8	
Electrostatic discharge capability (ESD) IN: (Human Body Model) ST: out to all other pins shorted:	V <sub>ESD</sub>	1.0 4.0 8.0	kV
acc. MIL-STD883D, method 3015.7 and ESD assn. std. S5.1-1993 R=1.5k $\Omega$ ; C=100pF			
Input voltage (DC) see internal circuit diagram page 9	V <sub>IN</sub>	-10 +16	V
Current through input pin (DC)	I <sub>IN</sub>	±0.3	mA
Pulsed current through input pin <sup>5)</sup>	I <sub>INp</sub>	±5.0	
Current through status pin (DC)	I <sub>ST</sub>	±5.0	

Supply voltages higher than  $V_{bb(AZ)}$  require an external current limit for the GND and status pins (a 150 $\Omega$ resistor for the GND connection is recommended.

 $R_{\rm I}$  = internal resistance of the load dump test pulse generator

<sup>3)</sup> V<sub>Load dump</sub> is setup without the DUT connected to the generator per ISO 7637-1 and DIN 40839

Device on 50mm\*50mm\*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70µm thick) copper area for V<sub>bb</sub> connection. PCB is vertical without blown air. See page 14

only for testing



#### **Thermal Characteristics**

Parameter and Conditions		Symbol		Values		
			min	typ	max	
Thermal resistance junction - soldering point <sup>6)7)</sup> junction – ambient <sup>6)</sup>	each channel:	R <sub>thjs</sub>			5	K/W
@ 6 cm <sup>2</sup> cooling area	one channel active: all channels active:			42 34		

### **Electrical Characteristics**

Parameter and Conditions, each of the four channels	Symbol		Values	;	Unit
at T <sub>j</sub> = -40+150°C, $V_{bb}$ = 12 V unless otherwise specified		min	typ	max	

#### **Load Switching Capabilities and Characteristics**

Load Switching Capabilities and Characteristics						
On-state resistance (V <sub>bb</sub> to OUT); I <sub>L</sub>	= 2 A					
each channel,	$T_{\rm j} = 25^{\circ}{\rm C}$ : $T_{\rm j} = 150^{\circ}{\rm C}$ :	R <sub>ON</sub>		70 140	90 180	mΩ
two parallel channel four parallel channel see diagram, page 11	Is, $T_j = 25^{\circ}\text{C}$ : Is, $T_j = 25^{\circ}\text{C}$ :			35 17.5	45 22.5	
		I <sub>L(NOM)</sub>	3.7 7.4 14.8	4.7 9.5 19.0		Α
Device on PCB <sup>6</sup> ), $T_a = 85$ °C, $T_j \le 150$ °C						
Output current while GND disconnected or pulled up <sup>8</sup> ); Vbb = 32 V, V <sub>IN</sub> = 0, see diagram page 9		/ <sub>L(GNDhigh)</sub>			2	mA
Turn-on time <sup>9)</sup> IN _	to 90% V <sub>OUT</sub> :	<i>t</i> on		100	250	μs
Turn-off time IN $\square$ $R_L = 12 \Omega$	to 10% V <sub>OUT</sub> :	$t_{ m off}$		100	270	
Slew rate on 9) 10 to 30% V <sub>0</sub>	OUT, $R_L = 12 \Omega$ :	d V/dt <sub>on</sub>	0.2		1.0	V/μs
Slew rate off 9) 70 to 40% $V_0$	OUT, $R_L = 12 \Omega$ :	-d V/dt <sub>off</sub>	0.2		1.1	V/μs

-

<sup>6)</sup> Device on 50mm\*50mm\*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70μm thick) copper area for V<sub>bb</sub> connection. PCB is vertical without blown air. See page 14

<sup>7)</sup> Soldering point: upper side of solder edge of device pin 15. See page 14

<sup>8)</sup> not subject to production test, specified by design

<sup>9)</sup> See timing diagram on page 12.



Parameter and Conditions, each of the four channels	Symbol		Values	3	Unit
at T <sub>j</sub> = -40+150°C, $V_{bb}$ = 12 V unless otherwise specified		min	typ	max	
Operating Parameters					
Operating voltage	V <sub>bb(on)</sub>	5.5		40	V
Undervoltage switch off <sup>10</sup> ) $T_j = -40^{\circ}\text{C}25^{\circ}\text{C}$ :	$V_{ m bb(u\ so)}$			4.5	V
$T_{\rm j}$ =125°C:				4.511)	
Overvoltage protection <sup>12)</sup> $I_{bb} = 40 \text{ mA}$	$V_{\rm bb(AZ)}$	41	47	52	V
Standby current <sup>13</sup> ) $T_j = -40^{\circ}\text{C}25^{\circ}\text{C}:$ $V_{IN} = 0$ ; see diagram page 11 $T_j = 150^{\circ}\text{C}:$	I <sub>bb(off)</sub>		9	20 30	μΑ
<i>T</i> <sub>j</sub> =125°C:				2011)	
Off-State output current (included in $I_{bb(off)}$ ) $V_{IN} = 0$ ; each channel	I <sub>L(off)</sub>		1	5	μΑ
Operating current <sup>14)</sup> , V <sub>IN</sub> = 5V,	_				
$I_{\text{GND}} = I_{\text{GND1}} + I_{\text{GND2}},$ one channel on: all channels on:	I <sub>GND</sub>		0.6 2.4	1.2 4.8	mA
Protection Functions <sup>15)</sup>					
Current limit, V <sub>out</sub> = 0V, (see timing diagrams, page 12)					
	I <sub>L(lim)</sub>			23	Α
Τ <sub>j</sub> =-40°C: Τ <sub>j</sub> =25°C: Τ <sub>j</sub> =+150°C:		9	15		
Repetitive short circuit current limit,		3			
$T_{\rm i} = T_{\rm it}$ each channel	I <sub>L(SCr)</sub>		12		Α
two,three or four parallel channels (see timing diagrams, page 12)	-L(001)		12		
Initial short circuit shutdown time $T_{j,start} = 25$ °C:	$t_{ m Off(SC)}$		2		ms
V <sub>out</sub> = 0V (see timing diagrams on page 12)					
Output clamp (inductive load switch off) <sup>16)</sup> at VON(CL) = Vbb - VOUT, IL= 40 mA	V <sub>ON(CL)</sub>	41	47	52	V
Thermal overload trip temperature	$T_{jt}$	150			°C
Thermal hysteresis	$\Delta T_{\rm jt}$		10		K

<sup>&</sup>lt;sup>10)</sup> is the voltage, where the device doesn't change it's switching condition for 15ms after the supply voltage falling below Vbb(on)

<sup>11)</sup> not subject to production test, specified by design

Supply voltages higher than  $V_{bb(AZ)}$  require an external current limit for the GND and status pins (a 150 $\Omega$  resistor for the GND connection is recommended). See also  $V_{ON(CL)}$  in table of protection functions and circuit diagram on page 9.

<sup>13)</sup> Measured with load; for the whole device; all channels off

<sup>14)</sup> Add  $I_{ST}$ , if  $I_{ST} > 0$ 

<sup>15)</sup> Integrated protection functions are designed to prevent IC destruction under fault conditions described in the data sheet. Fault conditions are considered as "outside" normal operating range. Protection functions are not designed for continuous repetitive operation.

<sup>&</sup>lt;sup>16)</sup> If channels are connected in parallel, output clamp is usually accomplished by the channel with the lowest VON(CL)



Parameter and Conditions, each of the four channels	Symbol		Values	i	Unit
at T <sub>j</sub> = -40+150°C, $V_{bb}$ = 12 V unless otherwise specified		min	typ	max	
Reverse Battery					
Reverse battery voltage <sup>17</sup> )	- V <sub>bb</sub>			32	V
Drain-source diode voltage ( $V_{out} > V_{bb}$ ) $I_L = -2.0 \text{ A}, T_j = +150 ^{\circ} \text{C}$	-V <sub>ON</sub>		600		mV
Diagnostic Characteristics					
Open load detection voltage	$V_{\text{OUT(OL)}}$	1.7	2.8	4.0	V
Input and Status Feedback <sup>18)</sup>		0.5		0.5	1.0
Input resistance (see circuit page 9)	$R_{l}$	2.5	4.0	6.0	kΩ
Input turn-on threshold voltage	$V_{\rm IN(T+)}$			2.5	V
Input turn-off threshold voltage	$V_{IN(T-)}$	1.0			V
Input threshold hysteresis	$\Delta V_{\rm IN(T)}$		0.2		V
Status change after positive input slope <sup>19)</sup> with open load	t <sub>d(STon)</sub>		10	20	μS
Status change after positive input slope <sup>19)</sup> with overload	t <sub>d(STon)</sub>	30			μS
Status change after negative input slope with open load	t <sub>d(SToff)</sub>			500	μS
Status change after negative input slope <sup>19)</sup> with overtemperature	t <sub>d(SToff)</sub>			20	μS
Off state input current $V_{IN} = 0.4 \text{ V}$ :	I <sub>IN(off)</sub>	5		20	μΑ
On state input current $V_{IN} = 5 \text{ V}$ :	I <sub>IN(on)</sub>	10	35	60	μΑ
Status output (open drain)					
Zener limit voltage $I_{ST} = +1.6 \text{ mA}$ :	$V_{\rm ST(high)}$	5.4			V
ST low voltage $I_{ST} = +1.6 \text{ mA}$ :	$V_{\rm ST(low)}$			0.6	

Requires a 150  $\Omega$  resistor in GND connection. The reverse load current through the intrinsic drain-source diode has to be limited by the connected load. Power dissipation is higher compared to normal operating conditions due to the voltage drop across the drain-source diode. The temperature protection is not active during reverse current operation! Input and Status currents have to be limited (see max. ratings page 4 and circuit page 9).

 $<sup>^{\</sup>rm 18)}$  If ground resistors  $\rm R_{\rm GND}$  are used, add the voltage drop across these resistors.

<sup>19)</sup> not subject to production test, specified by design



#### **Truth Table**

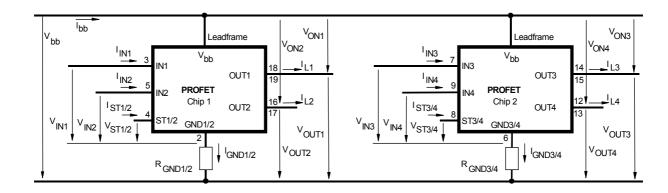
Channel 1 and 2	Chip 1	IN1	IN2	OUT1	OUT2	ST1/2
Channel 3 and 4	Chip 2	IN3	IN4	OUT3	OUT4	ST3/4
(equivalent to channel 1 and 2)						
Normal operation		L	L	L	L	Н
		L	Н	L	Н	Н
		Н	L	Н	L	Н
		Н	Н	Н	Н	Н
Open load	Channel 1 (3)	L	Х	Z	Х	L <sup>20</sup> )
		Н	Х	Н	X	н
	Channel 2 (4)	Х	L	Х	Z	L <sup>20</sup> )
		X	Н	Х	Н	Н
Overtemperature	both channel	L	L	L	L	Н
		X	Н	L	L	L
		Н	X	L	L	L
	Channel 1 (3)	L	Х	L	Х	Н
		Н	X	L	Х	L
	Channel 2 (4)	Х	L	Х	L	Н
		X	Н	X	L	L

L = "Low" Level H = "High" Level X = don't care

Z = high impedance, potential depends on external circuit Status signal valid after the time delay shown in the timing diagrams

Parallel switching of channel 1 and 2 (also channel 3 and 4) is easily possible by connecting the inputs and outputs in parallel (see truth table). If switching channel 1 to 4 in parallel, the status outputs ST1/2 and ST3/4 have to be configured as a 'Wired OR' function with a single pull-up resistor.

#### **Terms**



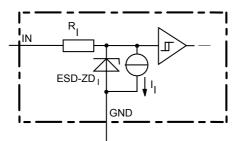
Leadframe (V<sub>bb</sub>) is connected to pin 1,10,11,20

External R<sub>GND</sub> optional; two resistors R<sub>GND1</sub>, R<sub>GND2</sub> = 150  $\Omega$  or a single resistor R<sub>GND</sub> = 75  $\Omega$  for reverse battery protection up to the max. operating voltage.

<sup>&</sup>lt;sup>20)</sup> L, if potential at the Output exceeds the OpenLoad detection voltage

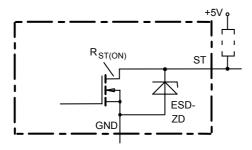


#### Input circuit (ESD protection), IN1 to IN4



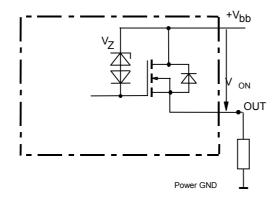
The use of ESD zener diodes as voltage clamp at DC conditions is not recommended.

#### Status output, ST1/2 or ST3/4



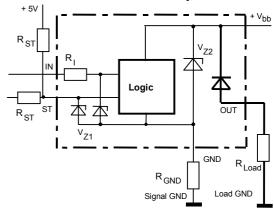
ESD-Zener diode: 6.1 V typ., max 0.3 mA;  $R_{ST(ON)}$  < 375  $\Omega$  at 1.6 mA. The use of ESD zener diodes as voltage clamp at DC conditions is not recommended.

# Inductive and overvoltage output clamp, OUT1...4



 $V_{\text{ON}}$  clamped to  $V_{\text{ON(CL)}} = 47 \text{ V typ.}$ 

#### Overvolt. and reverse batt. protection

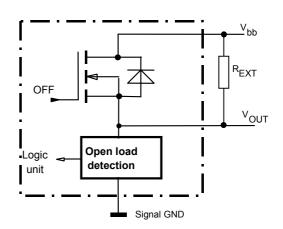


 $V_{Z1}$  = 6.1 V typ.,  $V_{Z2}$  = 47 V typ.,  $R_{GND}$  = 150 Ω,  $R_{ST}$ = 15 kΩ,  $R_{I}$ = 4.0 kΩ typ.

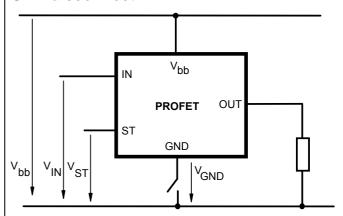
In case of reverse battery the load current has to be limited by the load. Temperature protection is not active

#### Open-load detection, OUT1...4

OFF-state diagnostic condition: Open Load, if  $V_{OUT} > 3$  V typ.; IN low



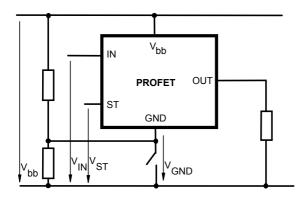
#### **GND** disconnect



Any kind of load. In case of IN=high is  $VOUT \approx VIN - VIN(T+)$ . Due to VGND > 0, no VST = low signal available.

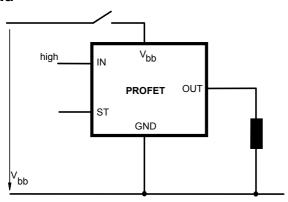


#### **GND** disconnect with GND pull up



Any kind of load. If  $V_{GND} > V_{IN} - V_{IN(T+)}$  device stays off Due to  $V_{GND} > 0$ , no  $V_{ST} = low$  signal available.

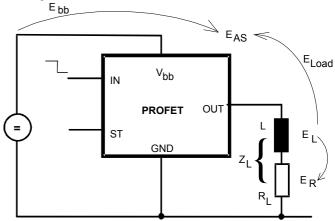
# V<sub>bb</sub> disconnect with energized inductive load



For inductive load currents up to the limits defined by  $Z_L$  (max. ratings and diagram on page 10) each switch is protected against loss of  $V_{hh}$ .

Consider at your PCB layout that in the case of Vbb disconnection with energized inductive load all the load current flows through the GND connection.

# Inductive load switch-off energy dissipation



Energy stored in load inductance:

$$E_L = \frac{1}{2} \cdot L \cdot I_1^2$$

While demagnetizing load inductance, the energy dissipated in PROFET is

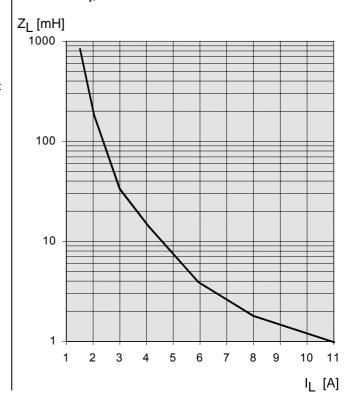
$$E_{AS} = E_{bb} + E_L - E_R = V_{ON(CL)} \cdot i_L(t) dt$$

with an approximate solution for  $R_L > 0 \Omega$ :

$$E_{AS} = \frac{I_L \cdot L}{2 \cdot R_L} (V_{bb} + |V_{OUT(CL)}|) ln (1 + \frac{I_L \cdot R_L}{|V_{OUT(CL)}|})$$

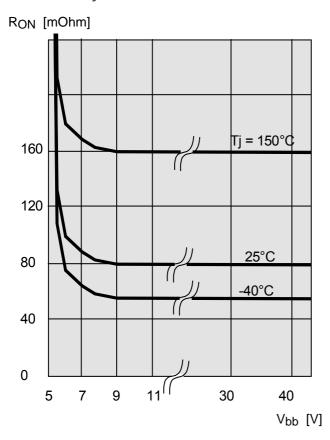
# Maximum allowable load inductance for a single switch off (one channel)<sup>4)</sup>

$$L = f(I_L)$$
; T<sub>j,start</sub> = 150°C, V<sub>bb</sub> = 12 V, R<sub>L</sub> = 0  $\Omega$ 



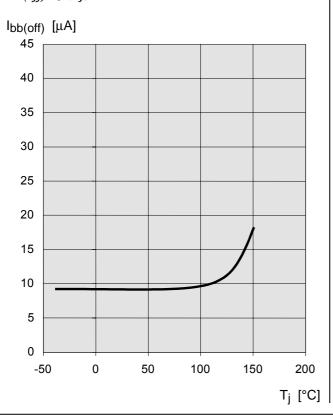


Typ. on-state resistance  $RoN = f(V_{bb}, T_j)$ ;  $I_L = 2 \text{ A}$ , IN = high



### Typ. standby current

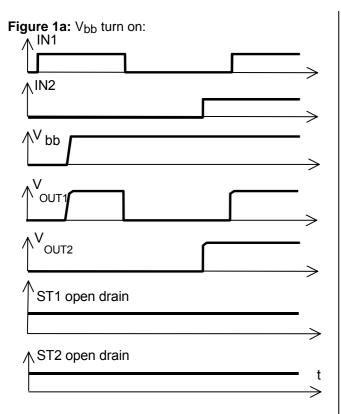
 $I_{bb(off)} = f(T_j)$ ;  $V_{bb} = 9...34 \text{ V}$ , IN1,2,3,4 = low





### **Timing diagrams**

All channels are symmetric and consequently the diagrams are valid for channel 1 to channel 4



**Figure 2a:** Switching a resistive load, turn-on/off time and slew rate definition:

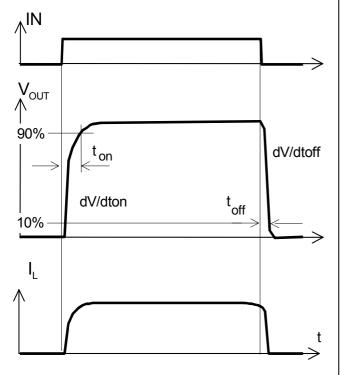
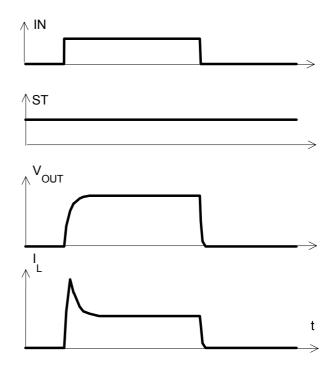
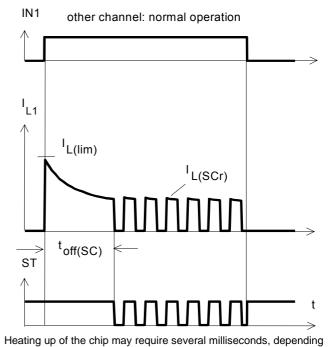


Figure 2b: Switching a lamp:



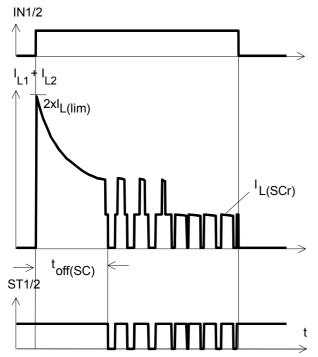
**Figure 3a:** Turn on into short circuit: shut down by overtemperature, restart by cooling



on external conditions

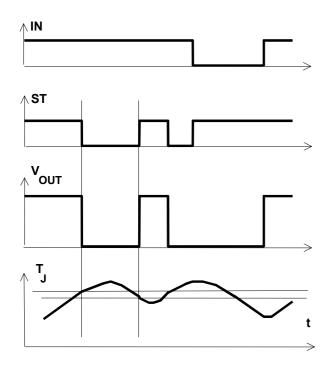


**Figure 3b:** Turn on into short circuit: shut down by overtemperature, restart by cooling (two parallel switched channels 1 and 2)



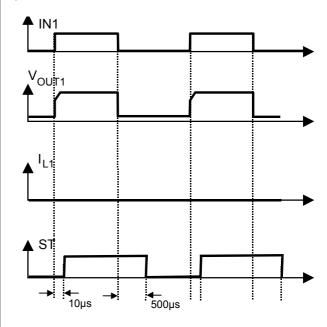
ST1 and ST2 have to be configured as a 'Wired OR' function ST1/2 with a single pull-up resistor.

**Figure 4a:** Overtemperature: Reset if  $T_i < T_{it}$ 



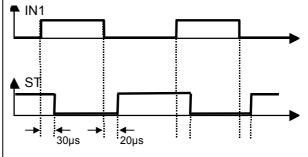
**Figure 5a:** Open load: detection in OFF-state, turn on/off to open load

Open load of channel 1; other channels normal operation



**Figure 6a:** Status change after, turn on/off to overtemperature

Overtemperature of channel 1; other channels normal operation



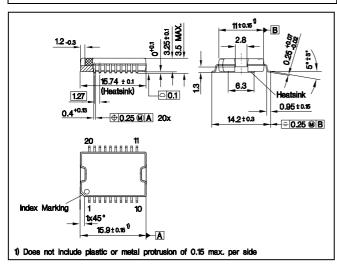


### Package and Ordering Code

#### Standard: P-DSO-20-12 (Power SO 20)

Sales Code	BTS 824R
Ordering Code	Q67060-S7027

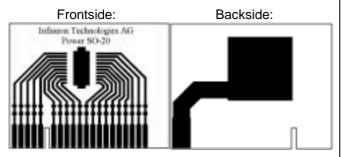
All dimensions in millimetres



Definition of soldering point with temperature  $T_s$ : upper side of solder edge of device pin 15.



Printed circuit board (FR4, 1.5mm thick, one layer 70 $\mu$ m, 6cm² active heatsink area) as a reference for max. power dissipation P<sub>tot</sub>, nominal load current I<sub>L(NOM)</sub> and thermal resistance R<sub>thja</sub>



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